



Universality of the tunable-barrier electron pump at the part-per-million level

Stephen Giblin
CPEM 2016
13th July 2016

“REUNIAM” 2008-2011



“QU-AMPERE”
2012-2015



EMRP
European Metrology Research Programme
Programme of EURAMET



“E-SI-AMP” 2016-2019
e-SI-AMP



NPL single electron group



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Nathan Johnson



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Masaya Kataoka



UNIVERSITY OF
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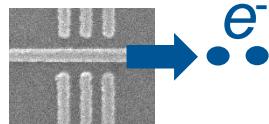
David Ritchie



Collaborators



KRISS



Myung-Ho Bae



Nam Kim

PTB



Dietmar Drung

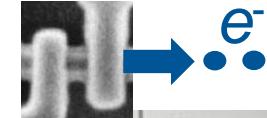


Christian Krause

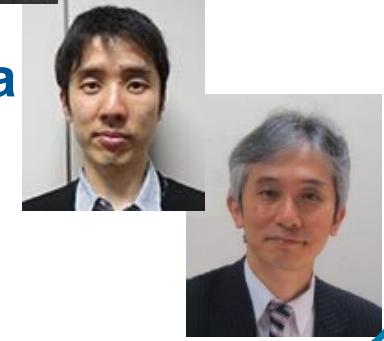


Friedericke Stein

NTT

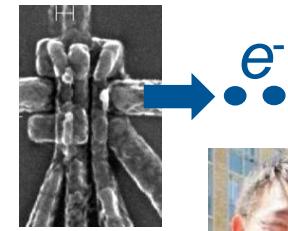


Gento Yamahata

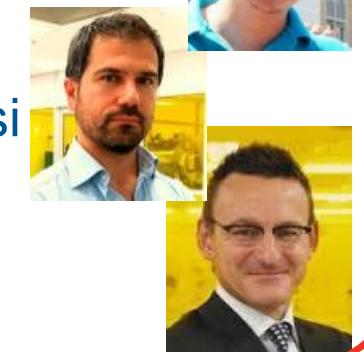


Akira Fujiwara

**UNSW
AUSTRALIA**



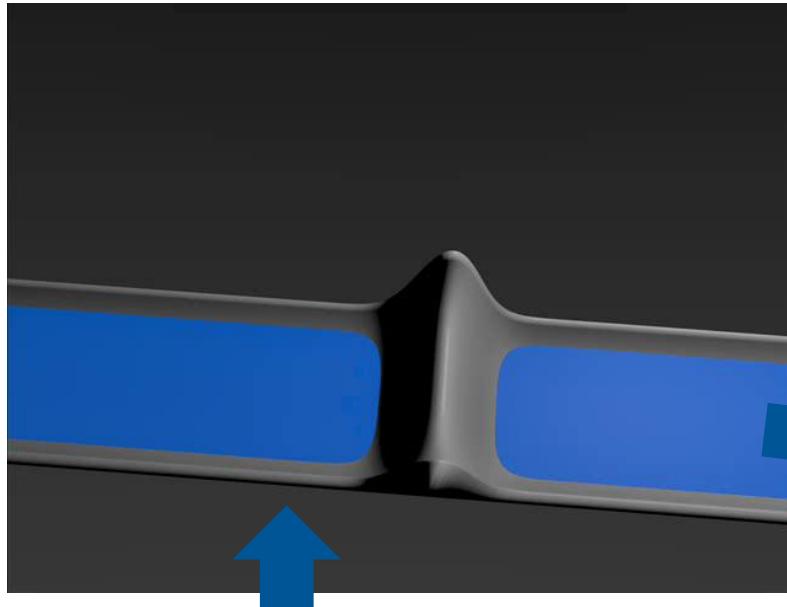
Ruichen Zao



Alessandro Rossi

Andrew Dzurak

The tunable-barrier pump



$V_G(t)$
Frequency f

Current I_P

$$f = 1 \text{ GHz} \longrightarrow I_P = 160 \text{ pA}$$

One-electron plateau:
 $I_P = ef$
Experimentally, we
measure ΔI_P :

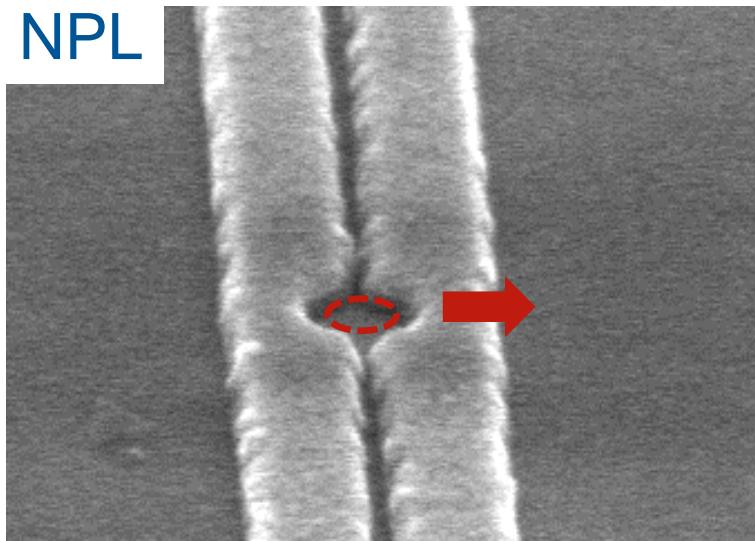
$$\Delta I_P = \frac{I_P - ef}{ef}$$

Device images

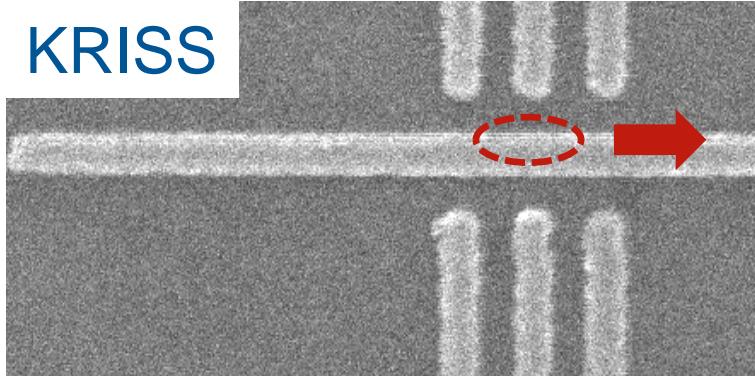
500 nm

Gallium Arsenide

NPL

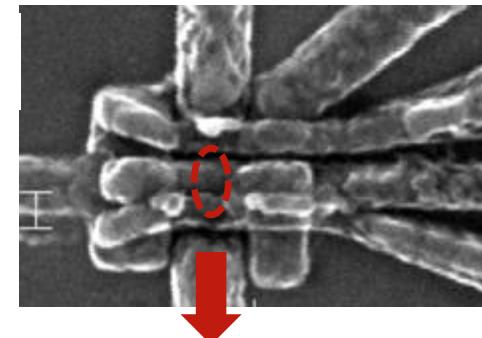


KRISS

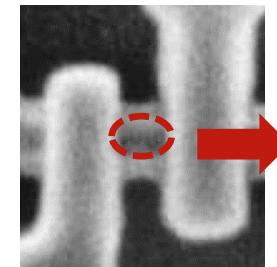


Silicon

UNSW



NTT

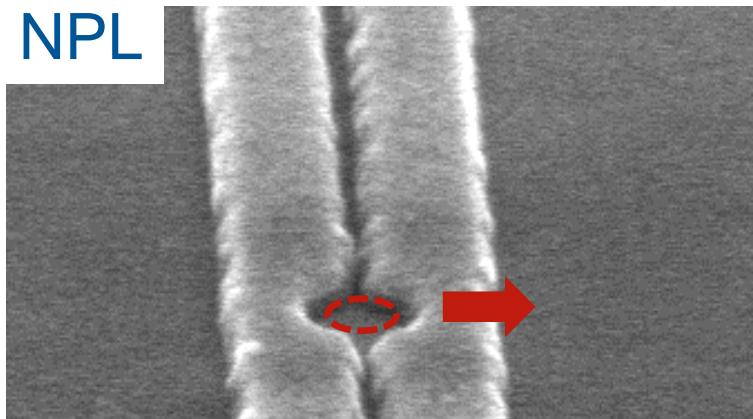


Device images

500 nm

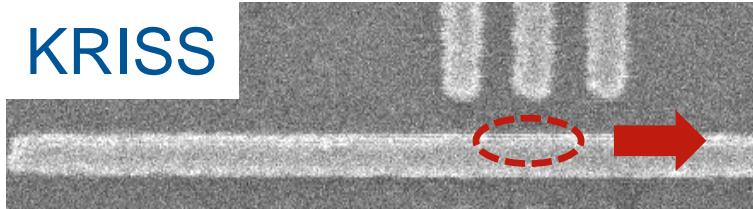
Gallium Arsenide

NPL



Giblin et al, *Nature Communications* 3, 930 (2012)

KRIS

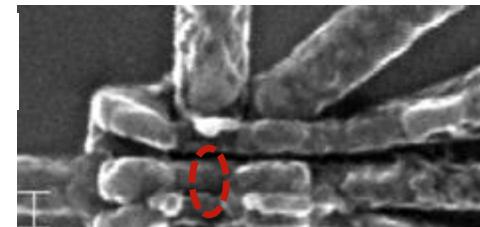


Ahn et al, *Phys. Rev. B.* **90**, 085307 (2014)

Bae et al, *Metrologia* **52**, 195 (2015)

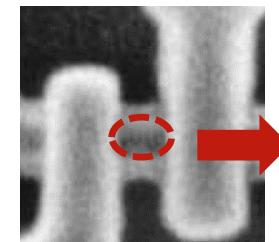
Silicon

UNSW



Rossi et al, *Nano Letters* **14**, 3405 (2014)

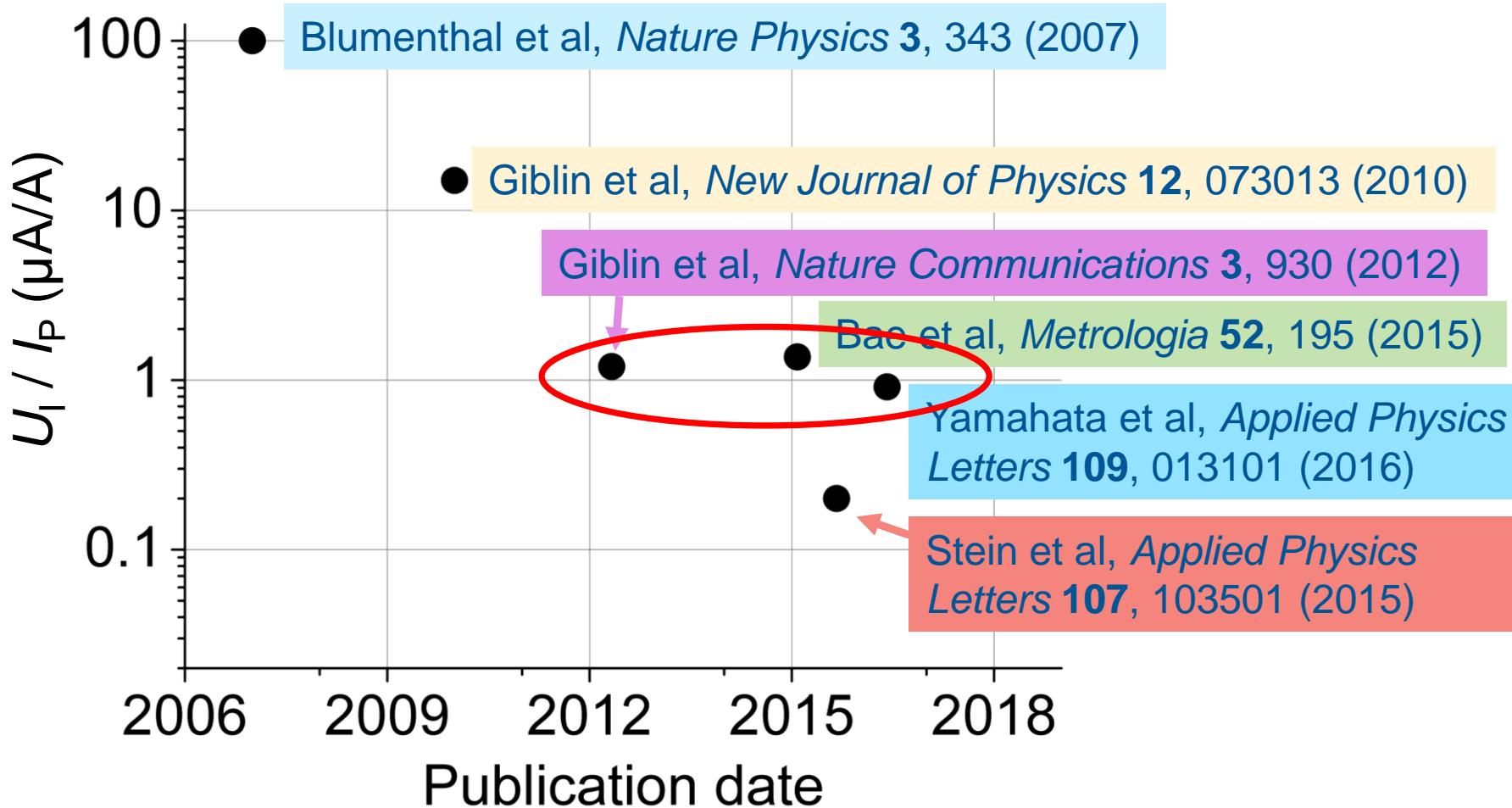
NTT



Fujiwara et al, *Appl. Phys. Lett.* **92**, 042102 (2008)
Yamahata et al, *APL* **109**, 013101 (2016)

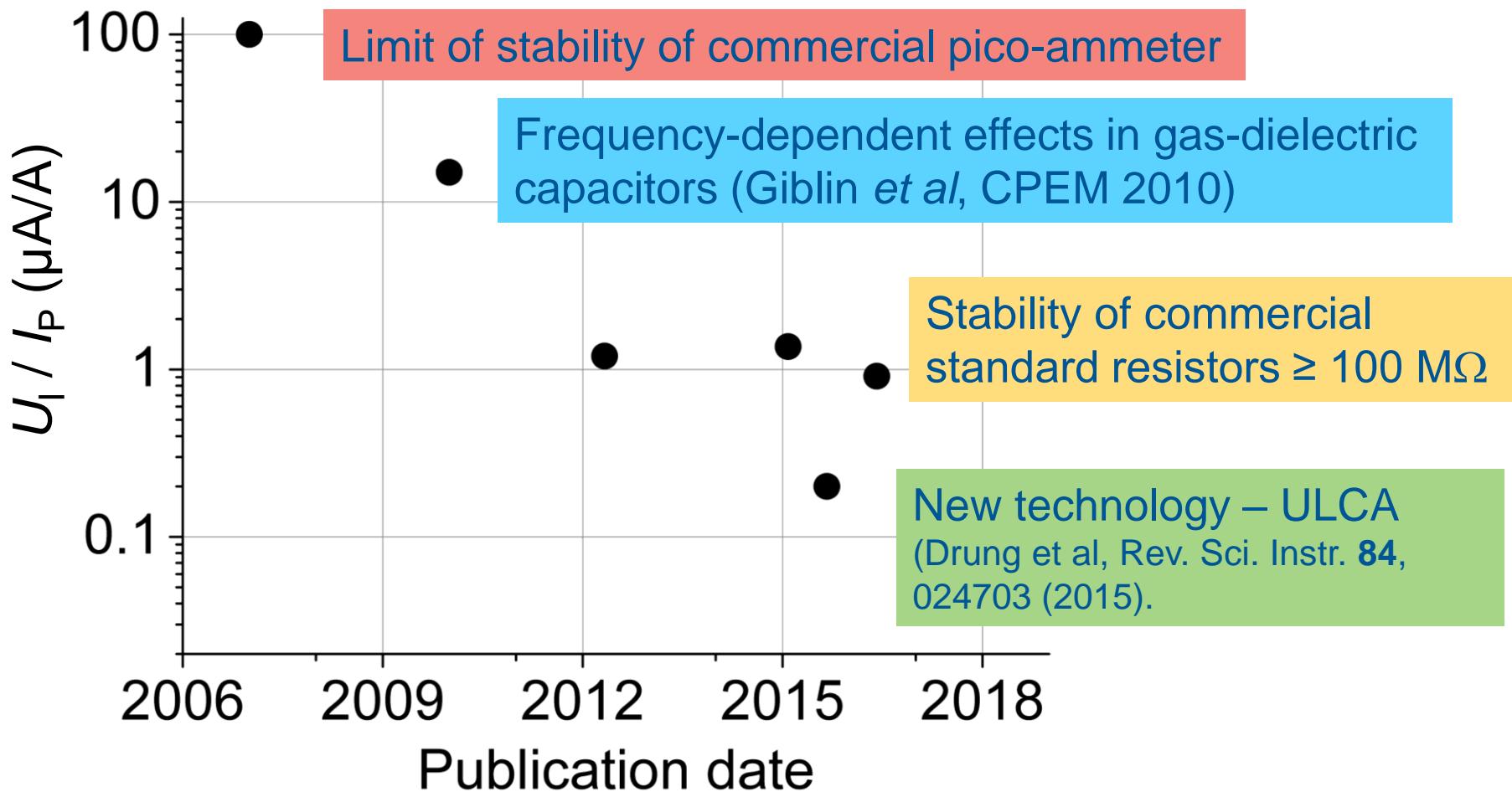
Historical overview

Accuracy of pump current measurements, $0.3 \text{ GHz} \leq f \leq 1 \text{ GHz}$
 $\Delta I_P < U_I / I_P$ in all cases



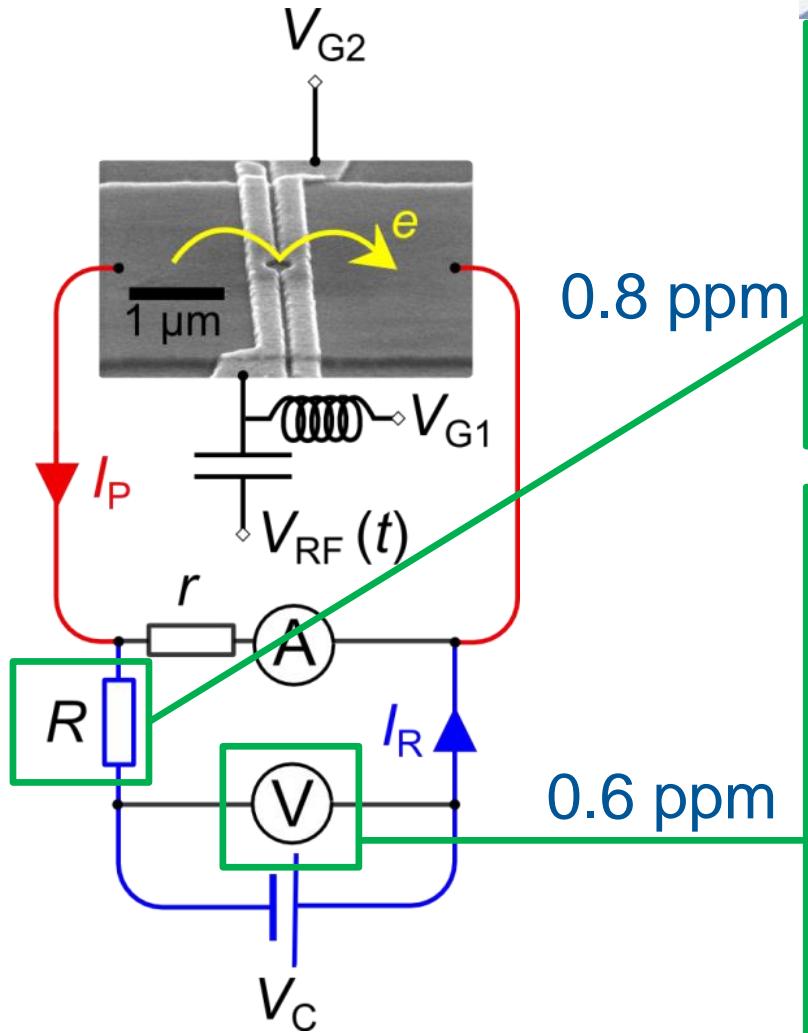
Historical overview

Requirement to measure pump current has pushed limits of existing small-current metrology



Pump current measurement I

Colin Porter
Clinton Kelly



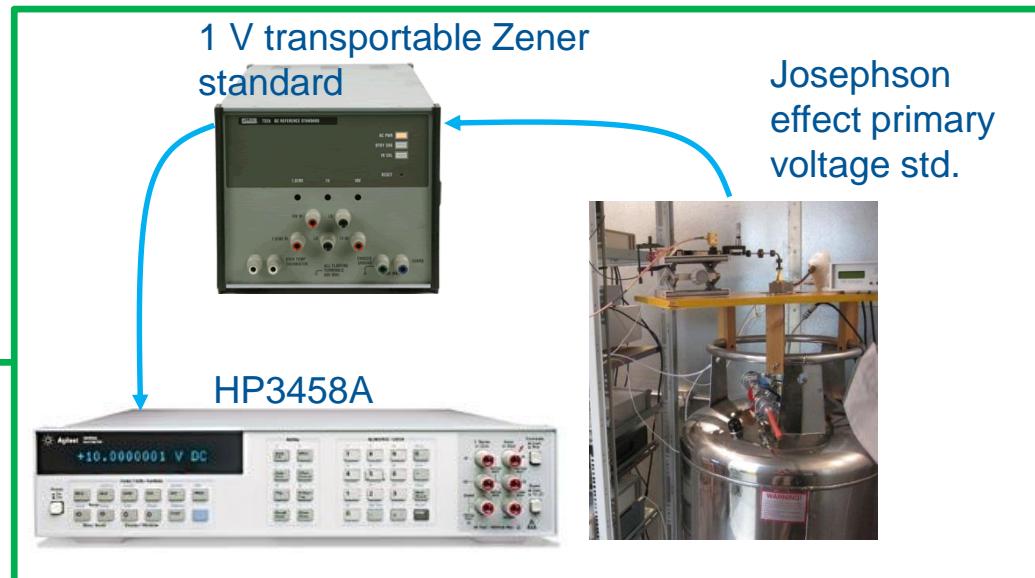
Guildline 9336 (thick-film)
Standard @ $\pm 0.005 \text{ C}$



NPL "Mk. 4" CCC

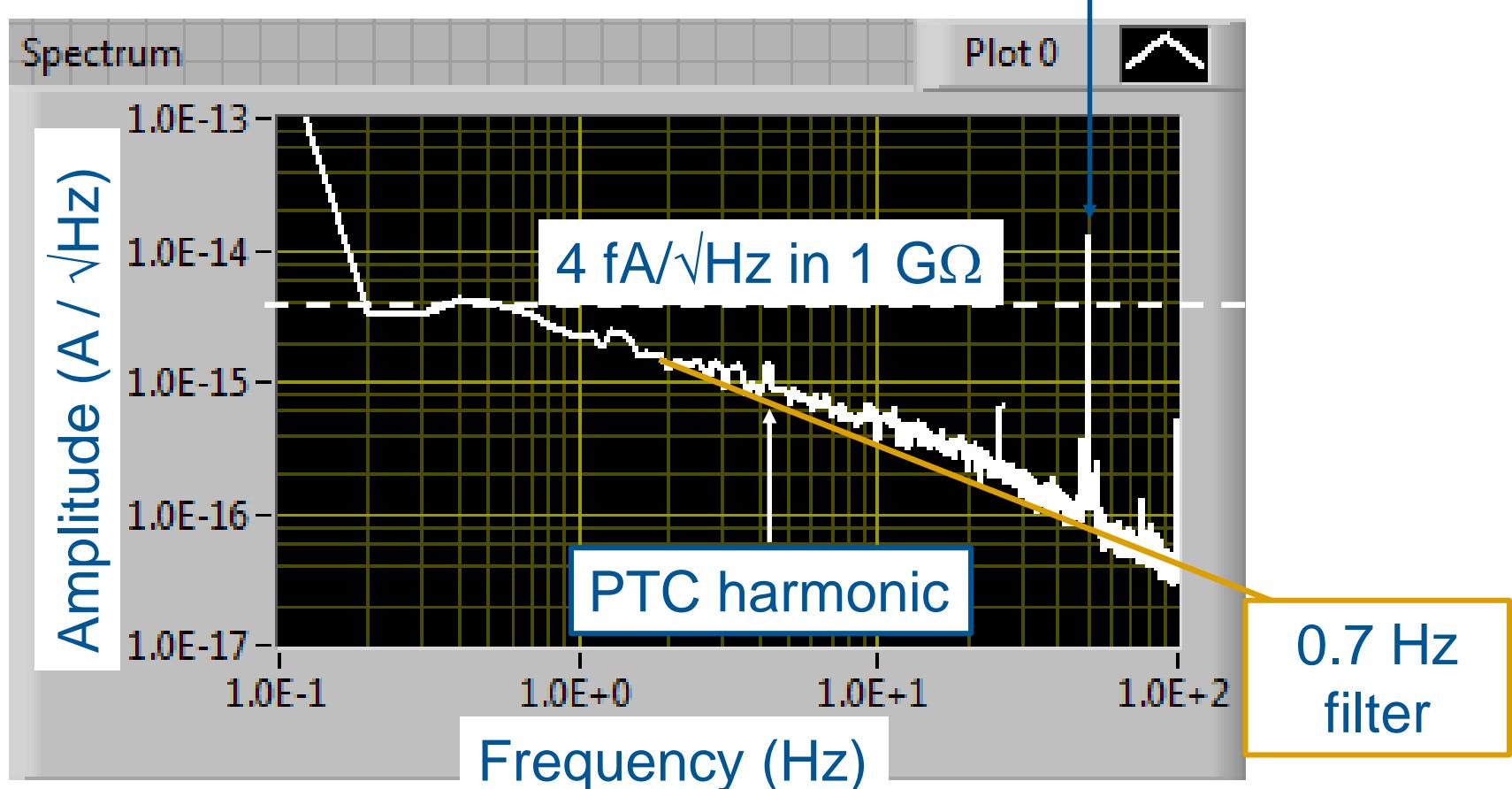
1 $\text{M}\Omega$	0.12
10 $\text{M}\Omega$	0.20
100 $\text{M}\Omega$	0.40
1 $\text{G}\Omega$	1.60

CMC (2- σ)

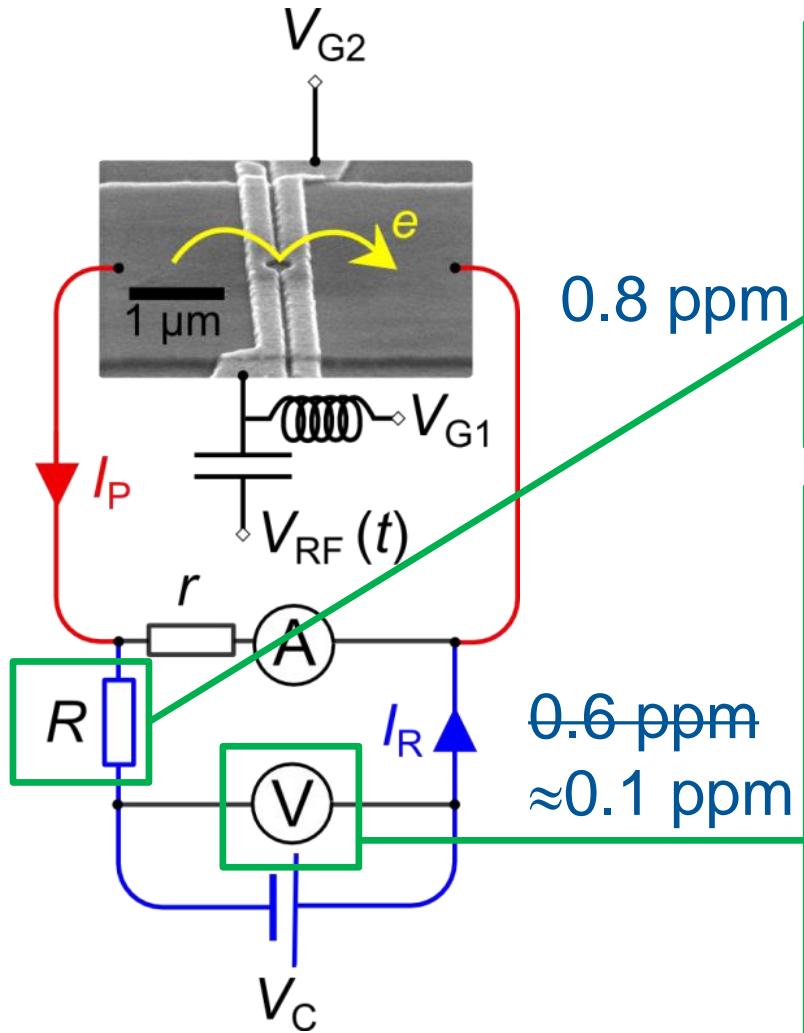


Ammeter noise spectrum

Femto DDPCA-300 on 10^{10} V/A



Pump current measurement II



Guildline 9336 (thick-film)
Standard @ ± 0.005 C



1 MΩ	0.12
10 MΩ	0.20
100 MΩ	0.40
1 GΩ	1.60

NPL "Mk. 4" CCC

CMC (2- σ)

Automated
scanner



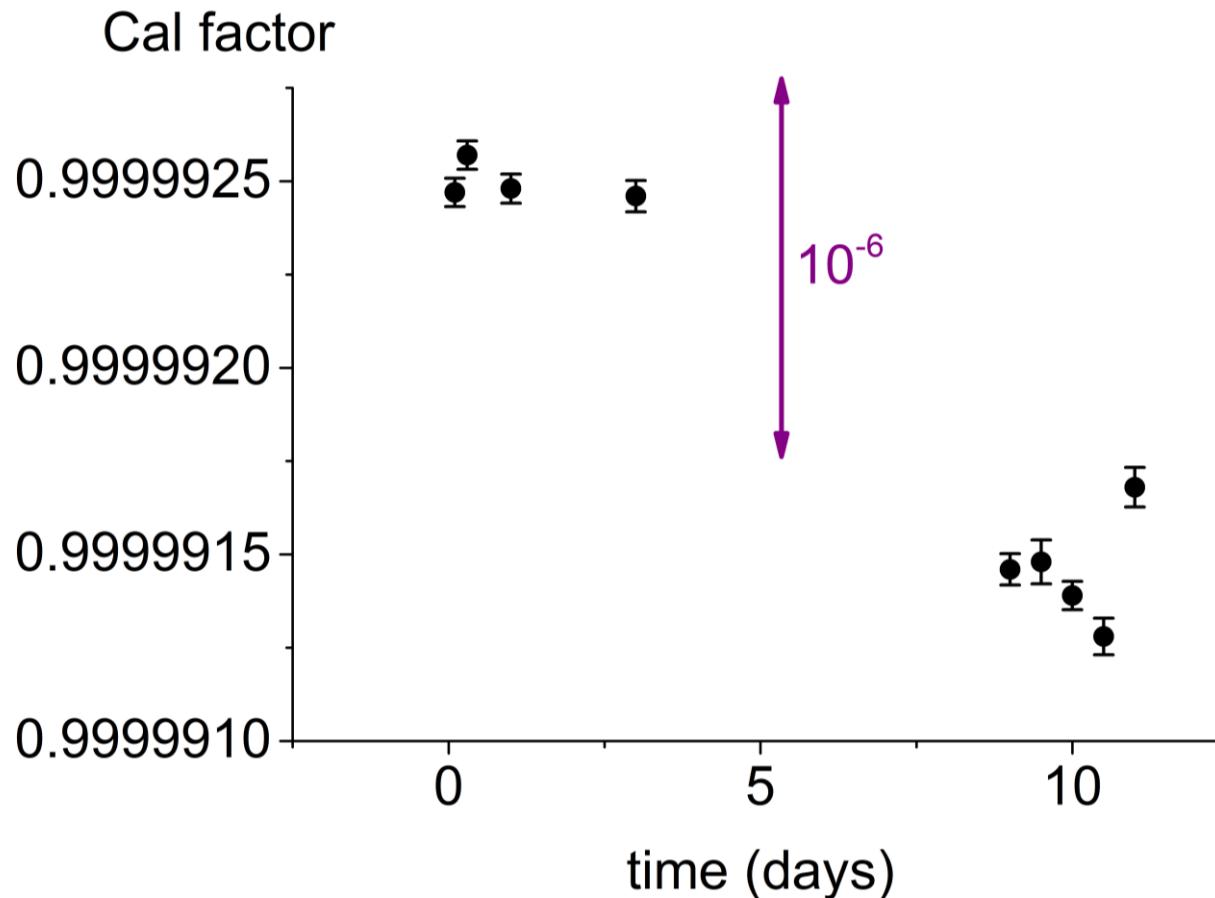
Josephson
effect primary
voltage std.

Direct calibration on $\approx 30 - m$
cable

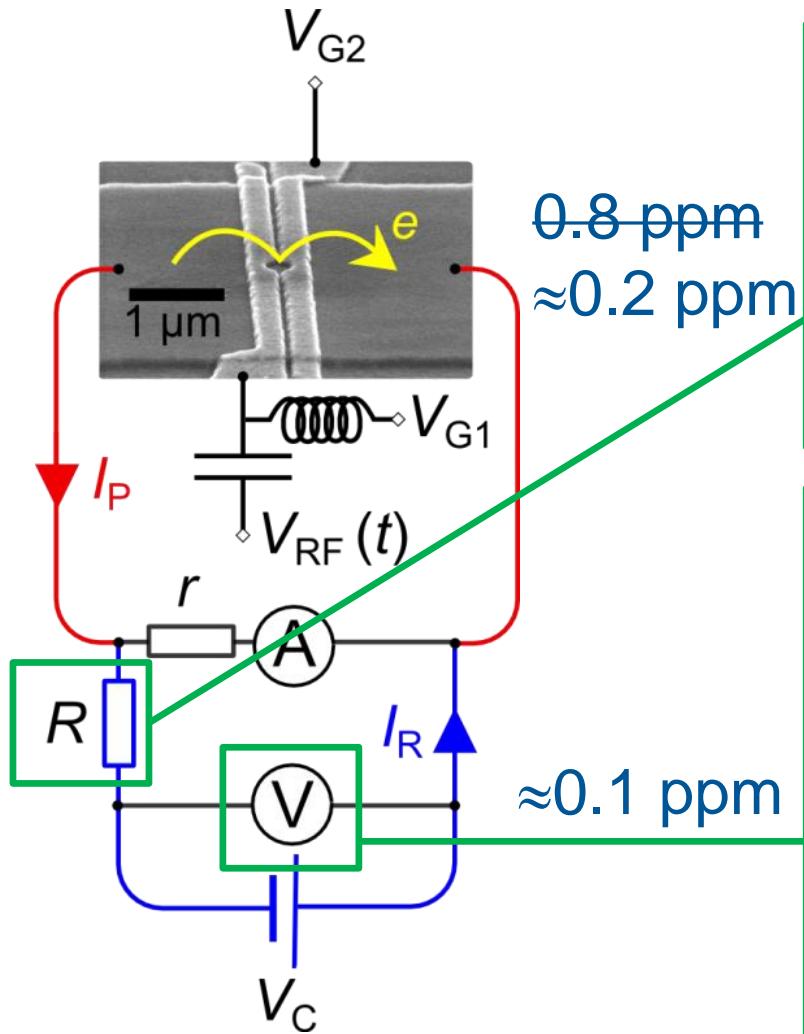
HP3458A



Typical stability of 3458A cal factor



Pump current measurement III



Error budgets are flawed
-J. Faller

Guildline 9336 (thick-film)
Standard @ $\pm 0.005 \text{ C}$



NPL "Mk. 4" CCC

Re-evaluate uncertainty budget
Ratio type B < 0.01 ppm
Type A ≈ 0.2 ppm
(to be published)



Automated scanner

Josephson effect primary voltage std.

Direct calibration on $\approx 30 - \text{m}$ cable

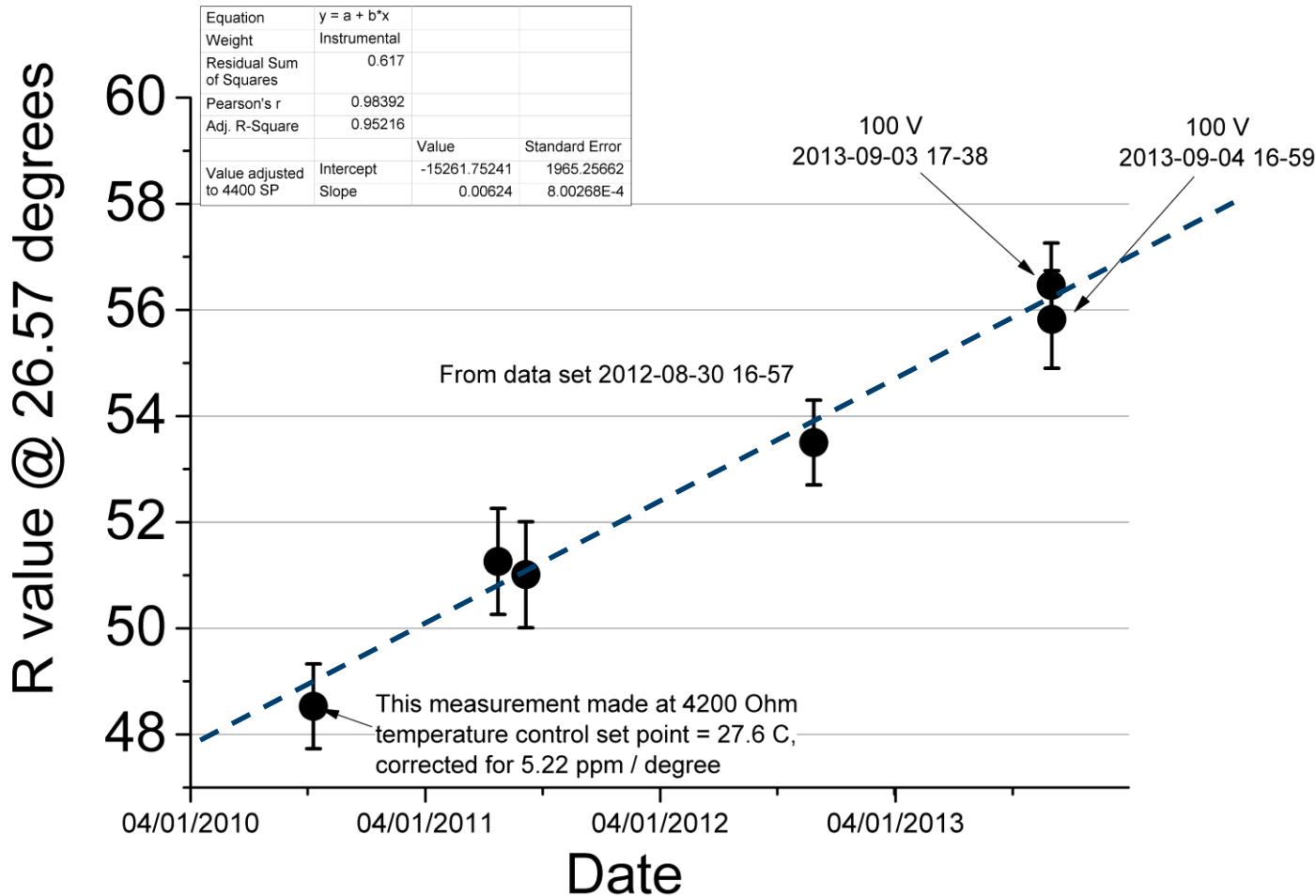


HP3458A



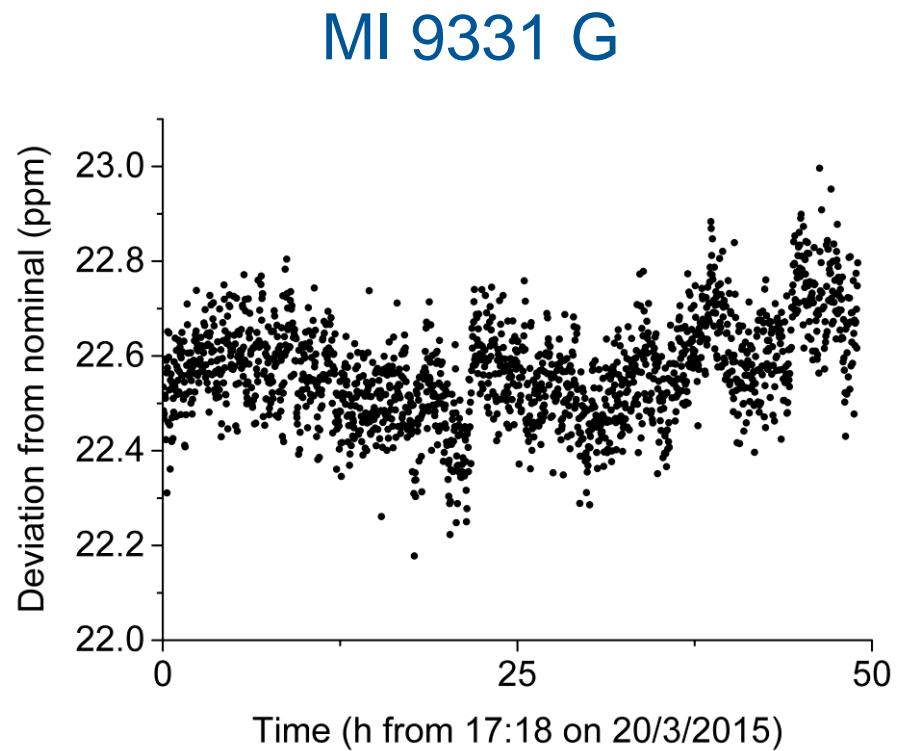
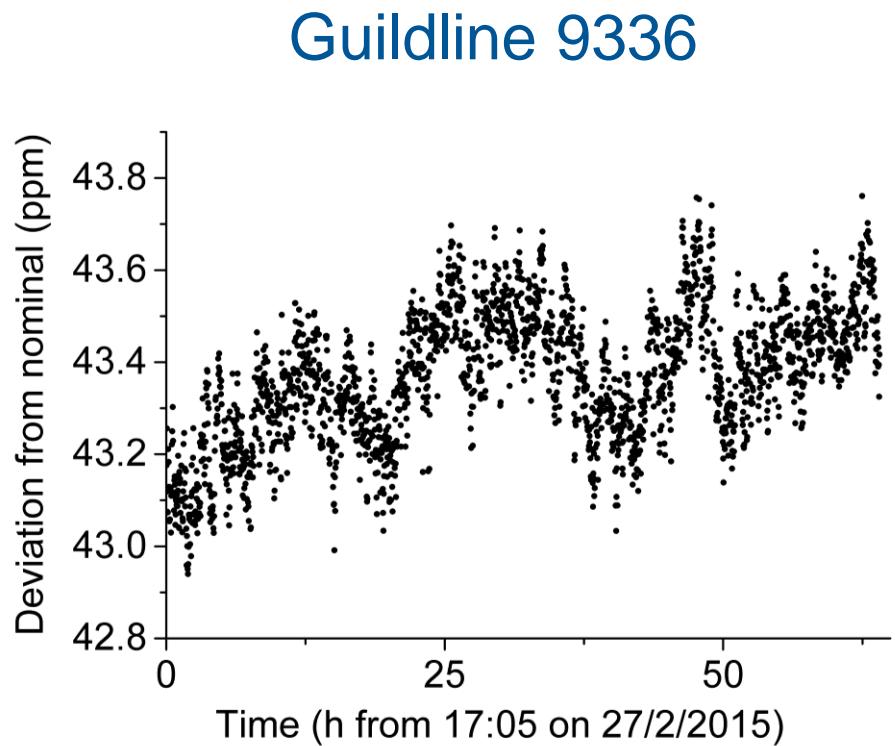
Resistor stability I

Pump measurements 2011-2015 based on long-term drift of resistor

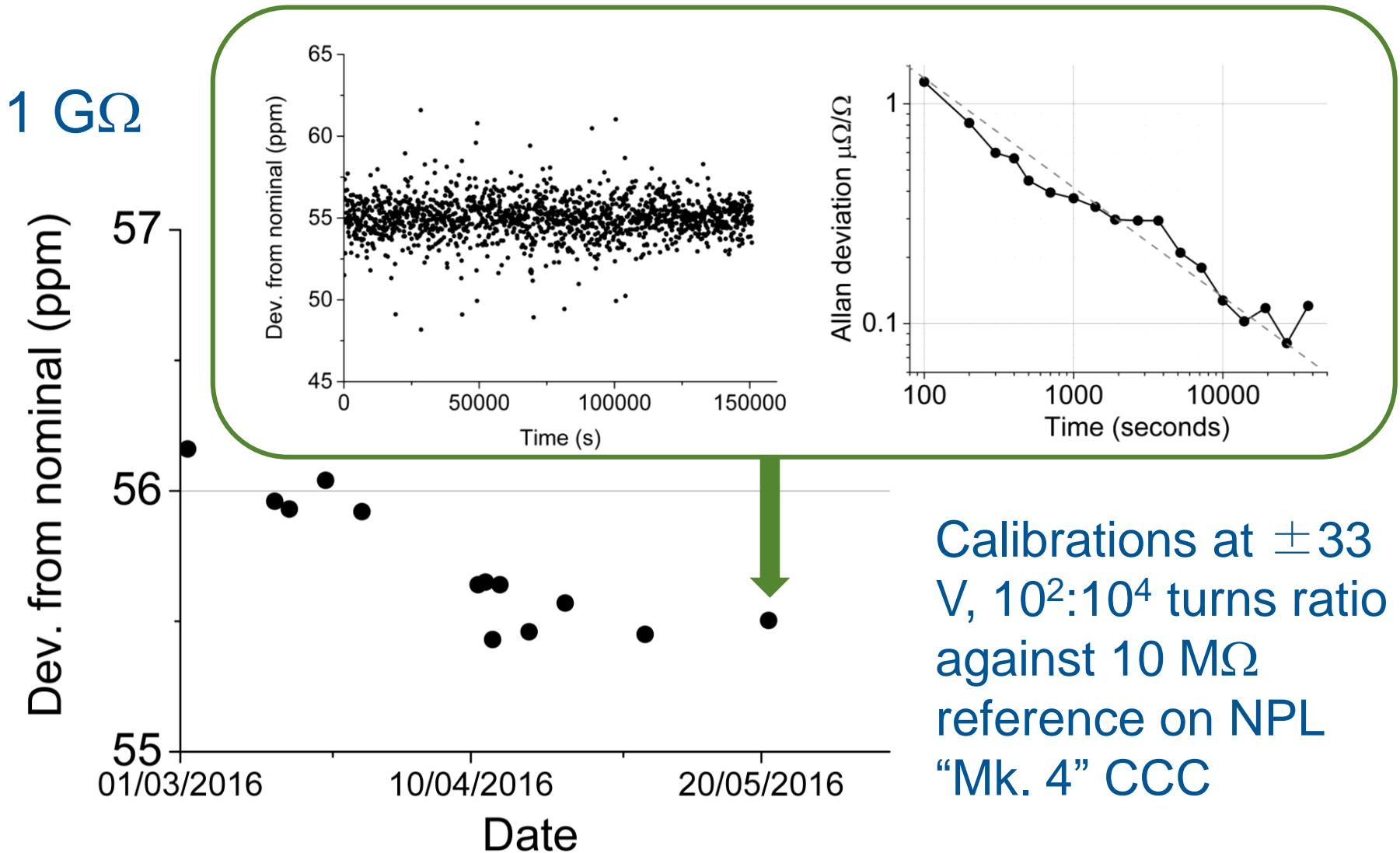


Resistor stability II

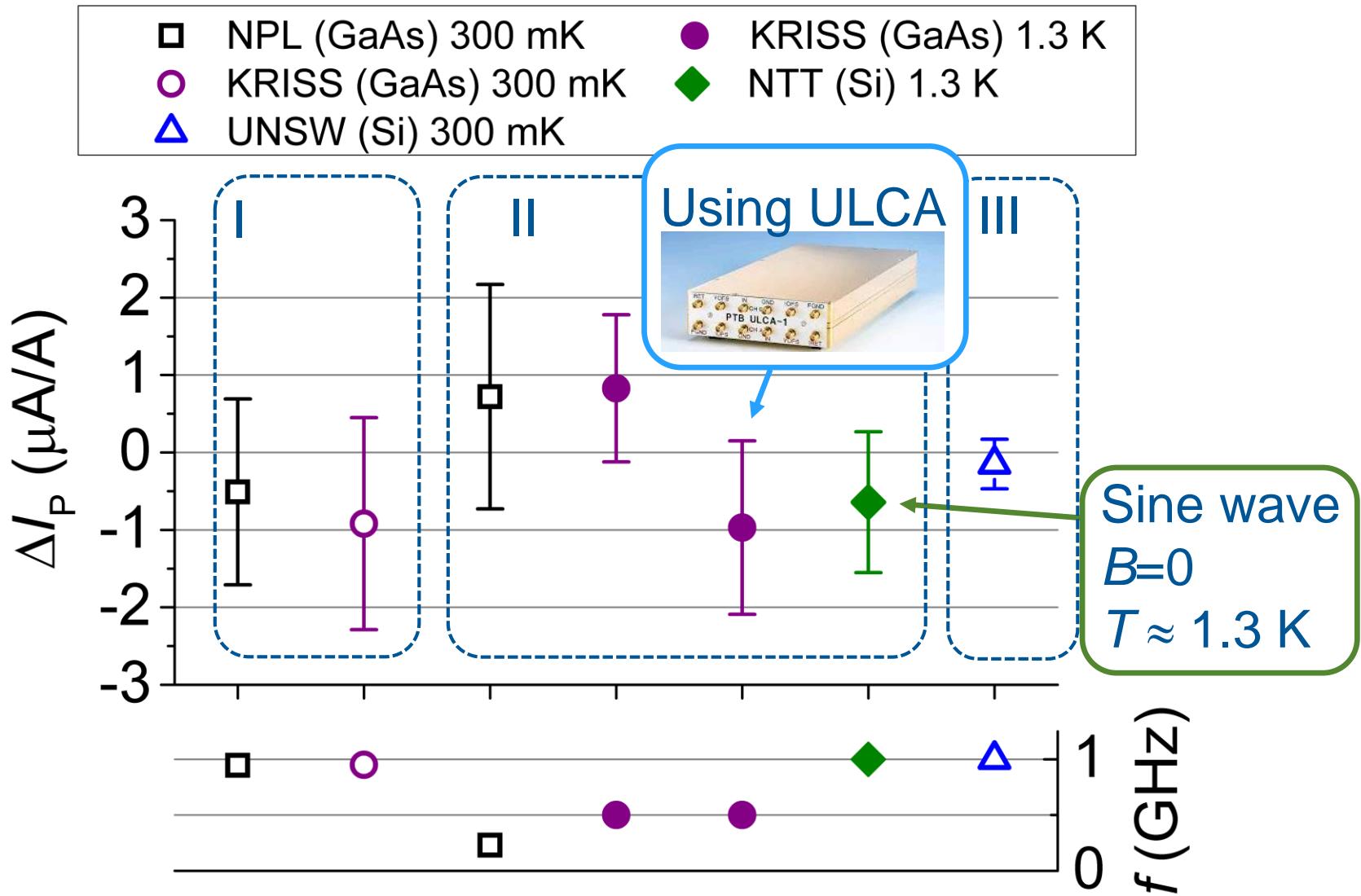
Evidence for short-term instability of thick-film standard resistors. These plots are both $100\text{ M}\Omega$ measured at 100 V



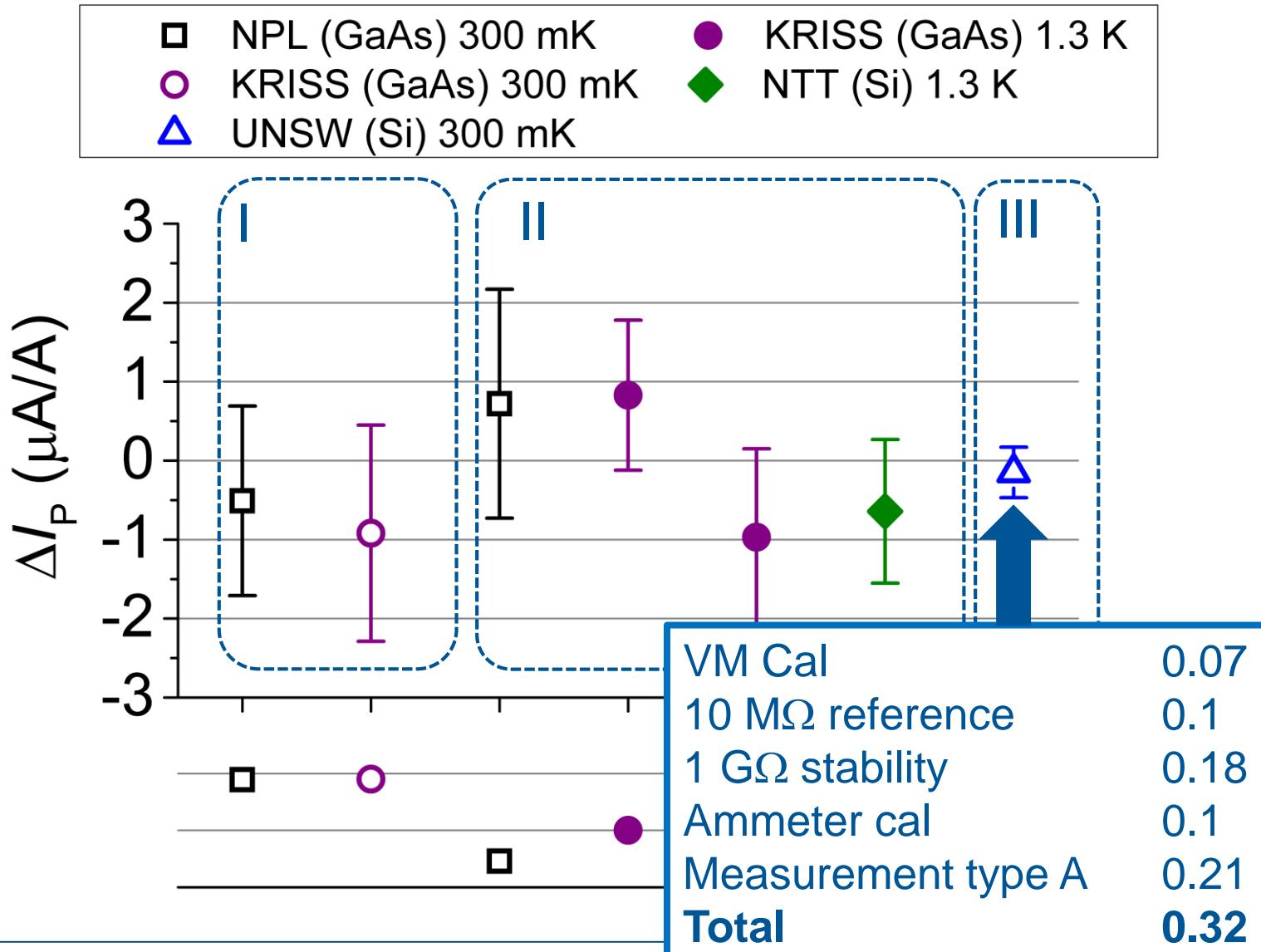
Resistor stability III



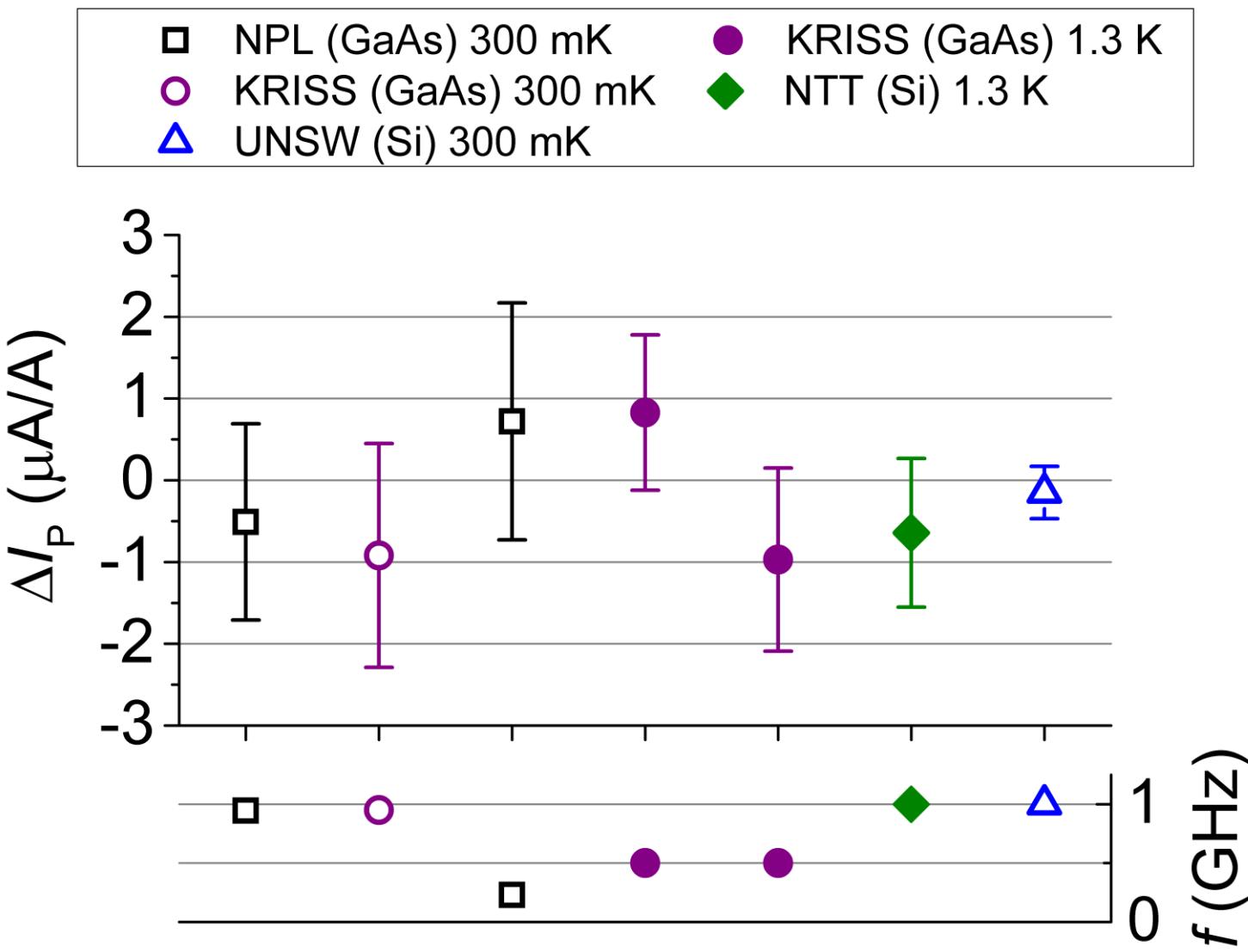
Results summary



Results summary

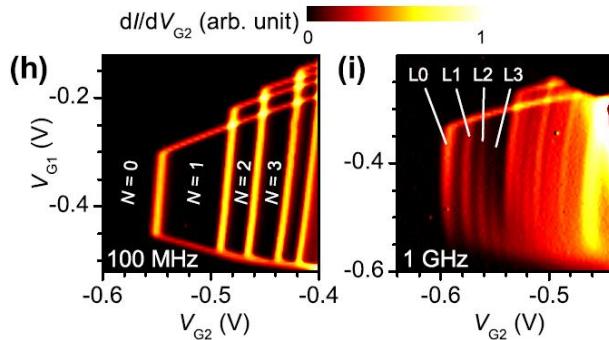


Results summary



Question: what determines upper frequency limit?

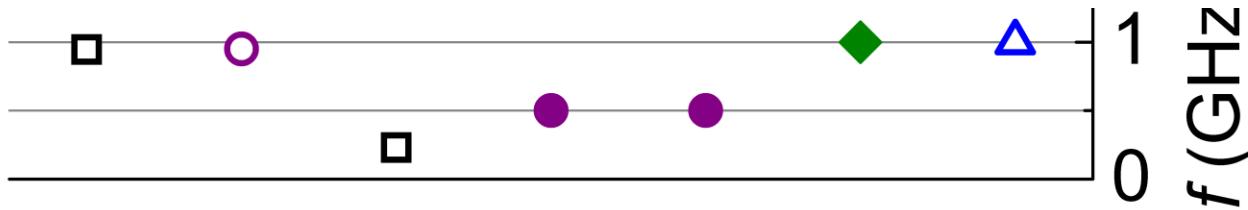
Non-adiabatic excitations?
Kataoka et al, *PRL* 106, 126801 (2011)



Circuit effects?

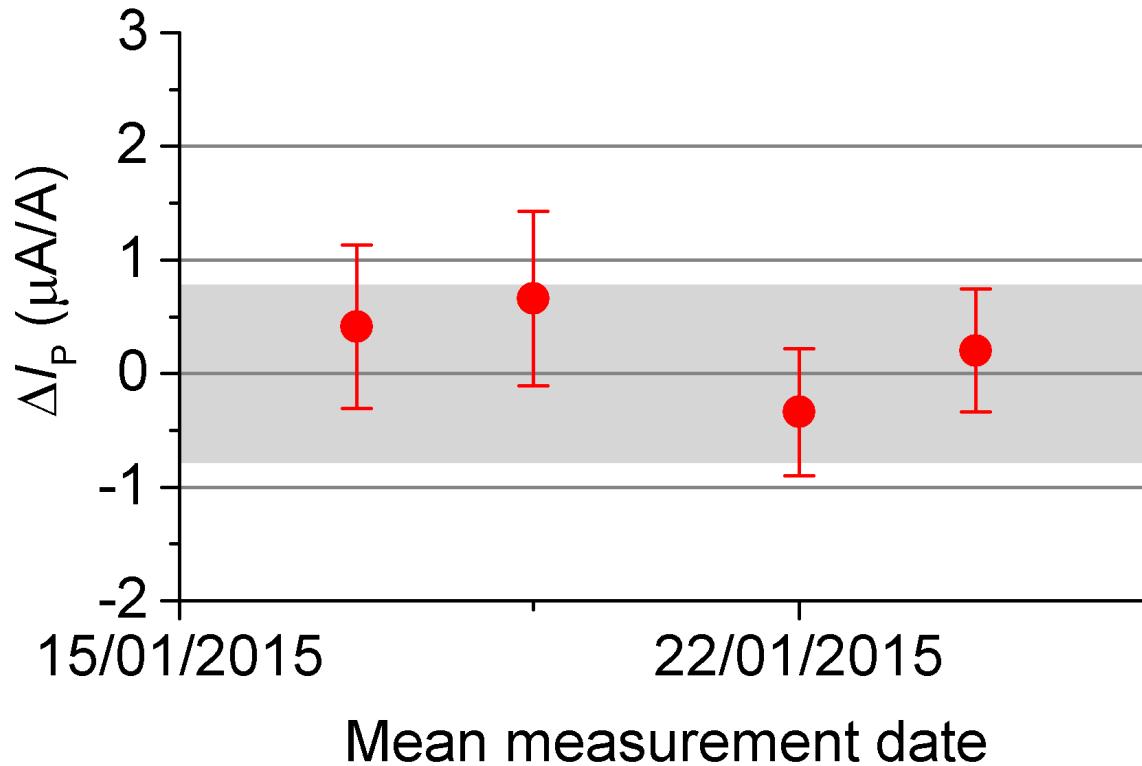


Difficult to get flat plateaus above 1 GHz



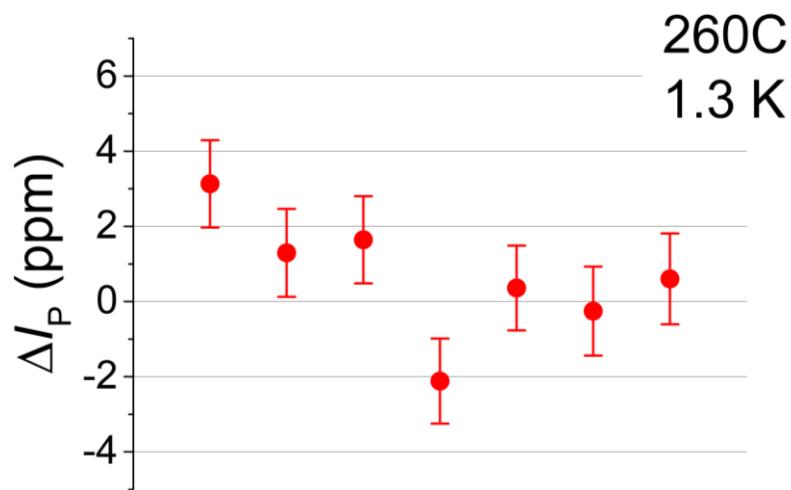
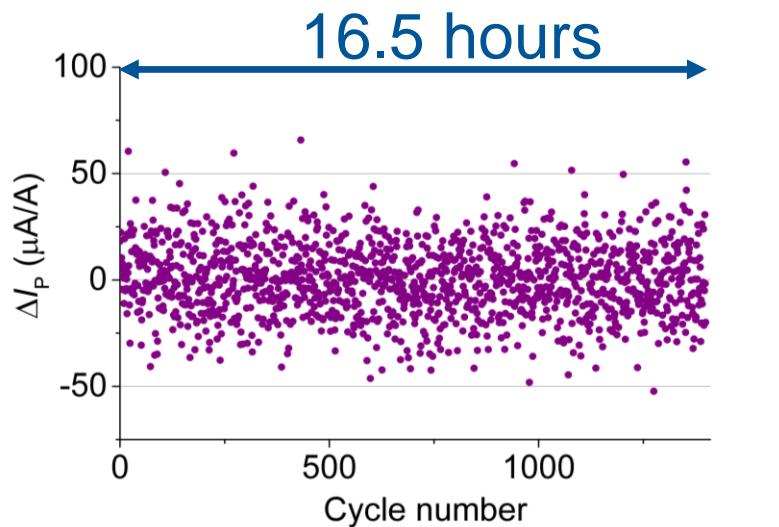
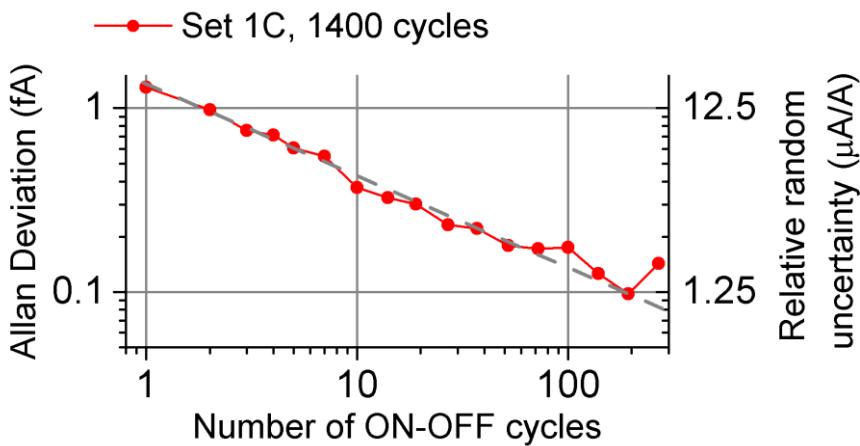
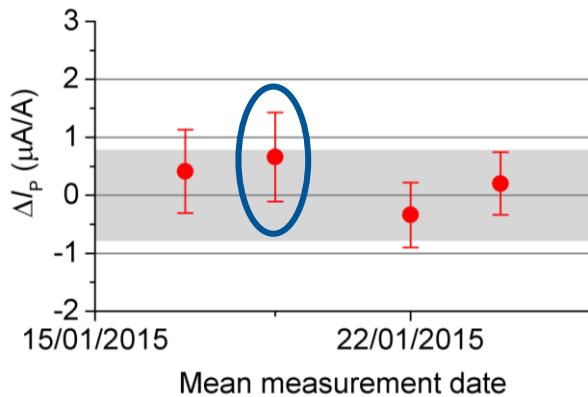
How stable is the pump?

Measurements at fixed operating point



How stable is the pump?

Longest continuous measurement to date:
KRISS pump, 1400 cycles





Department for Business Innovation & Skills

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Universal Decay Cascade Model for Dynamic Quantum Dot Initialization

Vyacheslavs Kashcheyevs^{1,2} and Bernd Kaestner³

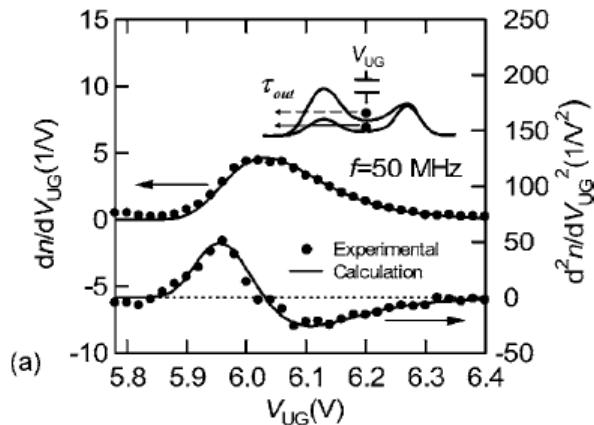
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(Received 26 January 2009; revised manuscript received 22 February 2010; published 7 May 2010)

042102-3 Fujiwara, Nishiguchi, and Ono



Fujiwara et al, *Appl. Phys. Lett.* **92**, 042102 (2008)

